Se	arcn	Notes	

Appli	cation/Control No.	Applicant(s)/Patent Reexamination	under
10/8	14,627	YASUI ET AL.	
Exam	niner	Art Unit	
Tonia	e M. Thomas	2822	

SEARCHED			
Class	Subclass	Date	Examiner
438	424	7/15/2005	ТМТ
•	431	7/15/2005	п
	435	7/15/2005	
10	437	7/15/2005	**
•	770-774	7/15/2005	н
19	907	7/15/2005	п
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
keyword search US-PGPUB USPAT EPO JPO DERWENT IBM_TDB	7/15/2005	тмт
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